

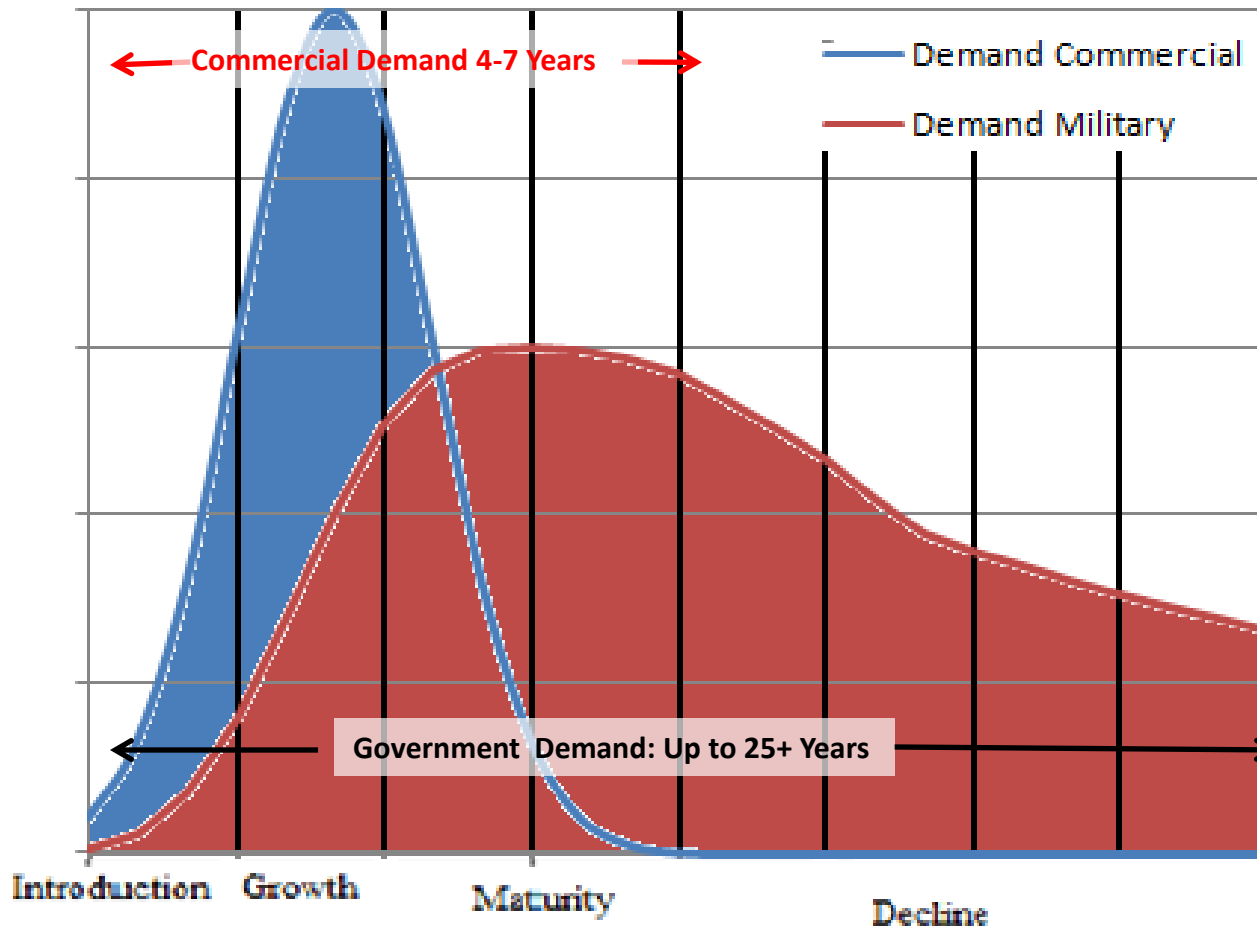


NI Aerospace and Defense Day 2013

Noah Reding

Automotive and Aerospace Product Manager

System Life Cycle Stages



- Military demand lags commercial demands
- Reduced budget
- Impacted weapon system acquisition
- Forced to extend the life of legacy systems
- Reductions in acquisition of replacement systems.

“Product Life Cycle Data Model,” American Standard ANSI/EIA-724, September 19, 1997.

1. Open System Approach

- Commercially-Off-The-Shelf (COTS) hardware for system development and quick prototyping
- Flexible Software Platform
- Local development of intellectual property and retaining know-how

2. Ecosystem

- Local domain expertise for Software Development
- Integration and Ruggedization
- Qualification testing
- Future Maintainability
- Specialized Research support

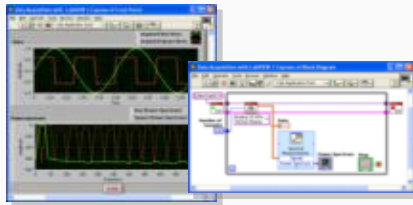
National Instruments – What We Do

Graphical system design combines graphical programming software with modular hardware, leveraging the latest technologies

Low-Cost Modular Measurement and Control Hardware



Productive Software Development Tools



Highly Integrated Systems Platforms



Build Better Systems Faster



Better
integration

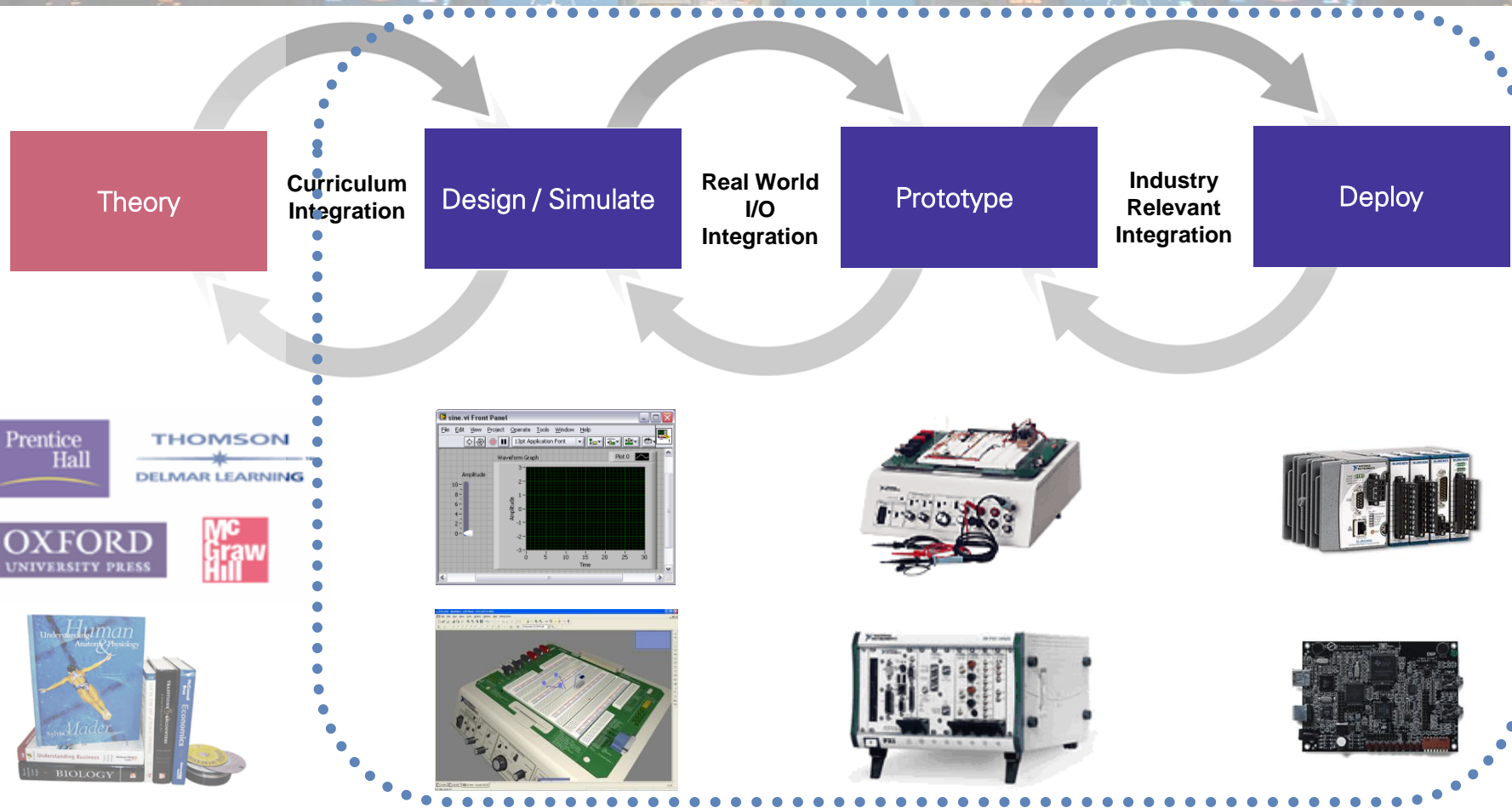


Lower Costs



Long-Term
Scalability

How does Graphical System Design Help?



Applications



Embedded RF



Automated Test



Control, Simulation and
Monitoring

Flight Termination
System Tester

Radio Communication
Test Set

Channel Emulator

HIL Simulators

Condition Monitoring
System

Satellite Emulation

Data Acquisition
System

Radar
Testing

Fault Signature
Analyzer

Software Defined
Radio

Spectrum
Monitoring

Radio
Navigation

EMCS

N-Channel Phase
Synchronized
Generation/ Acquisition

Multi-channel
Embedded Control
System

Fault Insertion
Unit

Threat Simulator

Structural ATE

Board ATE

Telecom Standards, IEEE
802.11/ 16, Bluetooth,
GSM, CDMA2K, WCDMA

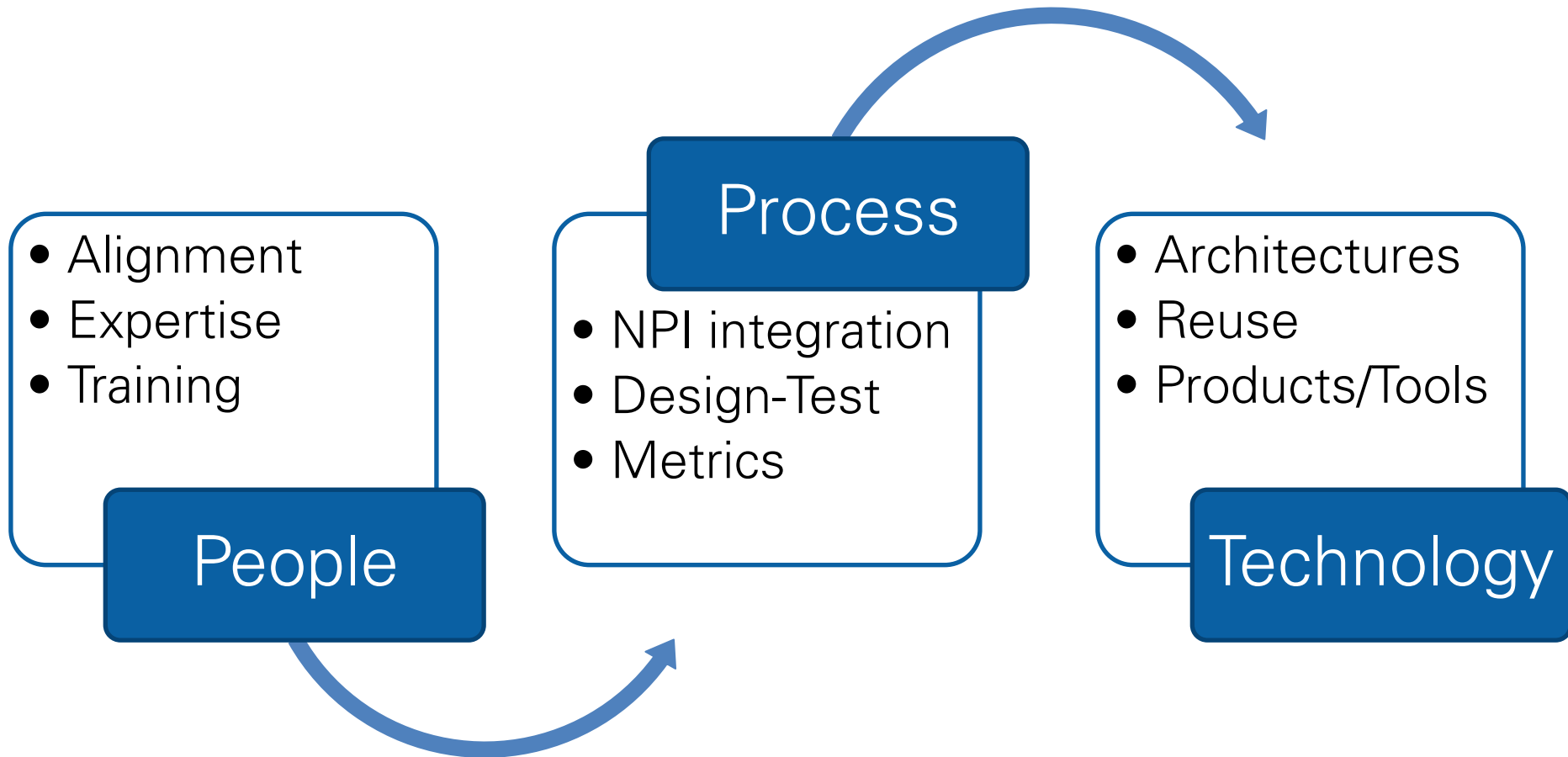
FADEC ATEs

Receiver Testing

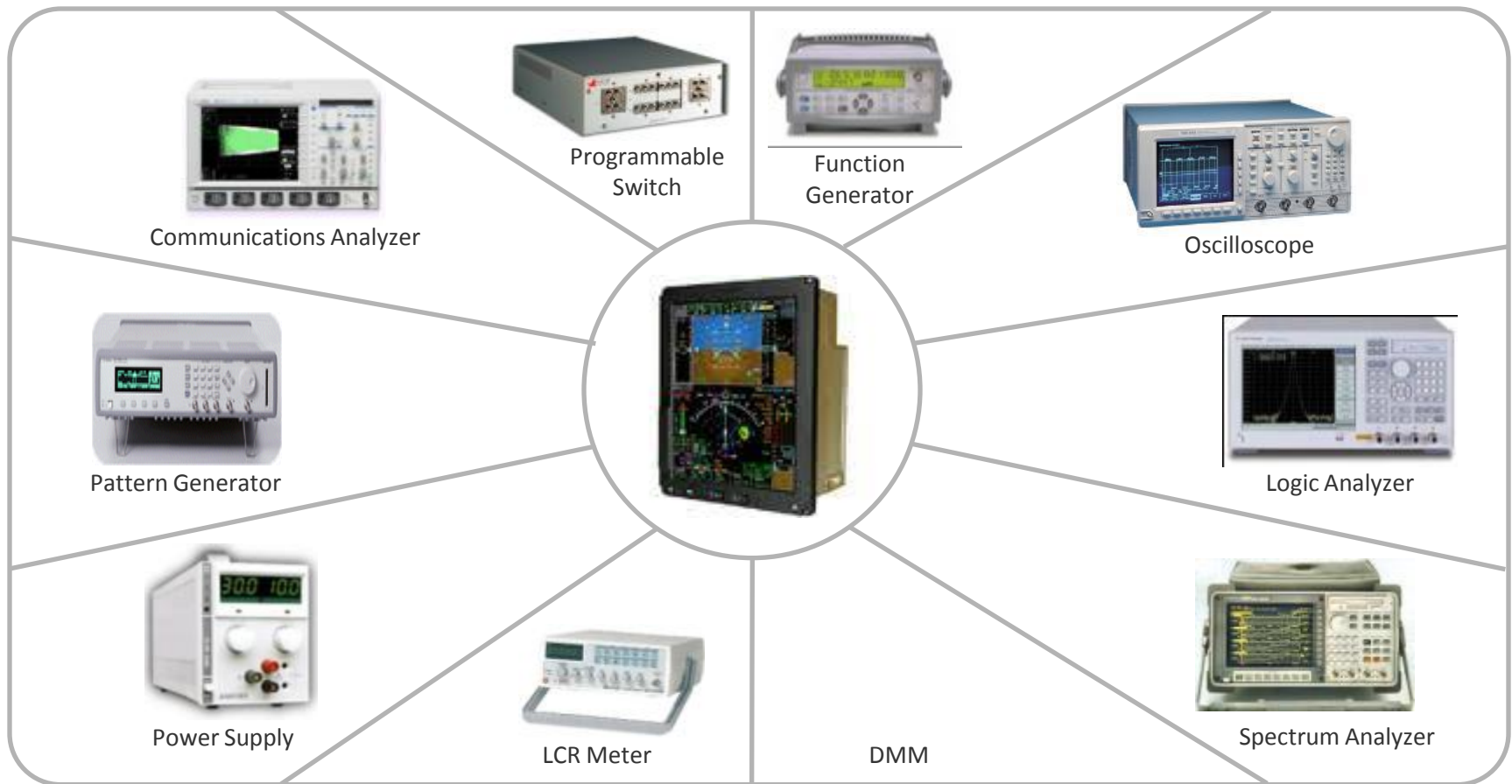
Wideband
Record &
Playback



Optimization for Test



The Traditional Approach

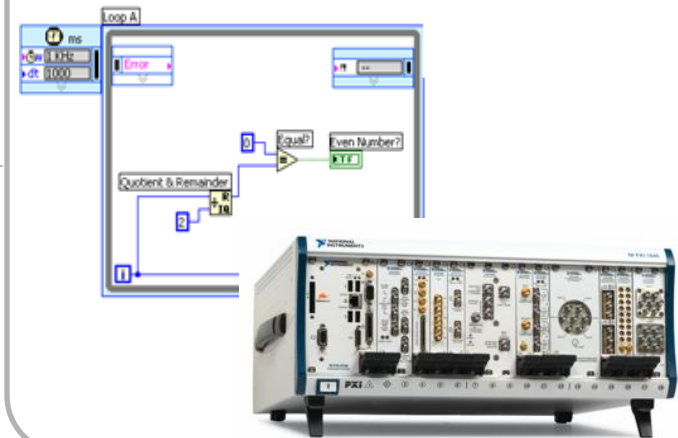


NI Graphical System Design Approach

Traditional Solution



PXI Solution



- Lower cost
- Higher performance
- Smaller size
- Flexibility
- Easily upgradable design
- User-defined solution

Pioneers of PXI Technology

Rugged,
industrial

Quad-Core CPU

PXI Express Backplane

Timing, Triggering, and Synchronization

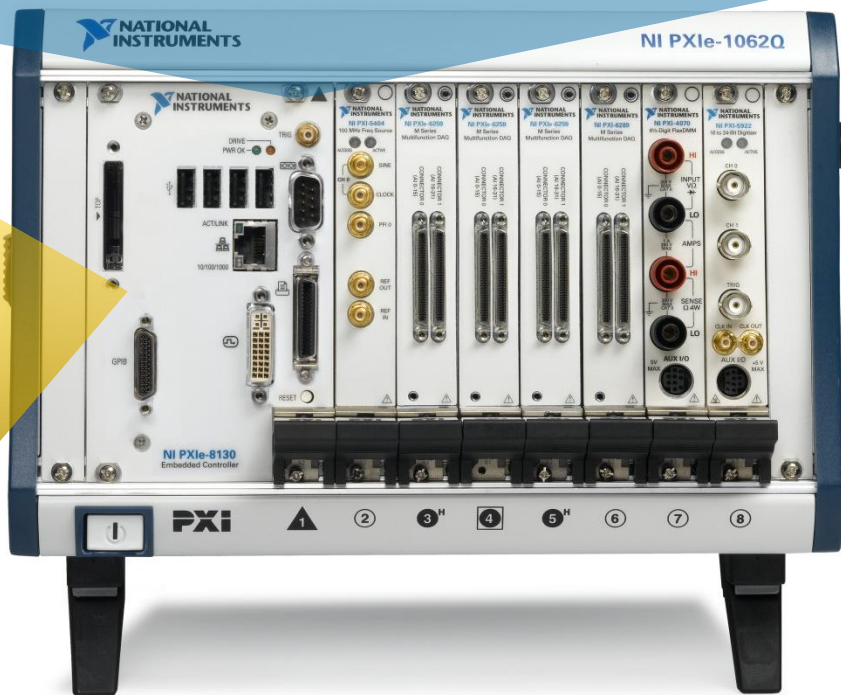
RF, FPGA, Digital IO, Analog IO

Windows or Real-Time OS

NI LabVIEW, NI TestStand

Application Specific Modules

Test Program Set



Embedded Software Quality Challenge

Smart Washing Machine



Commercial Aircraft



Luxury Automobile



Lines of Code

100k

6.5 Mil

10 Mil

10-20 defects produced per 1,000 lines of code*

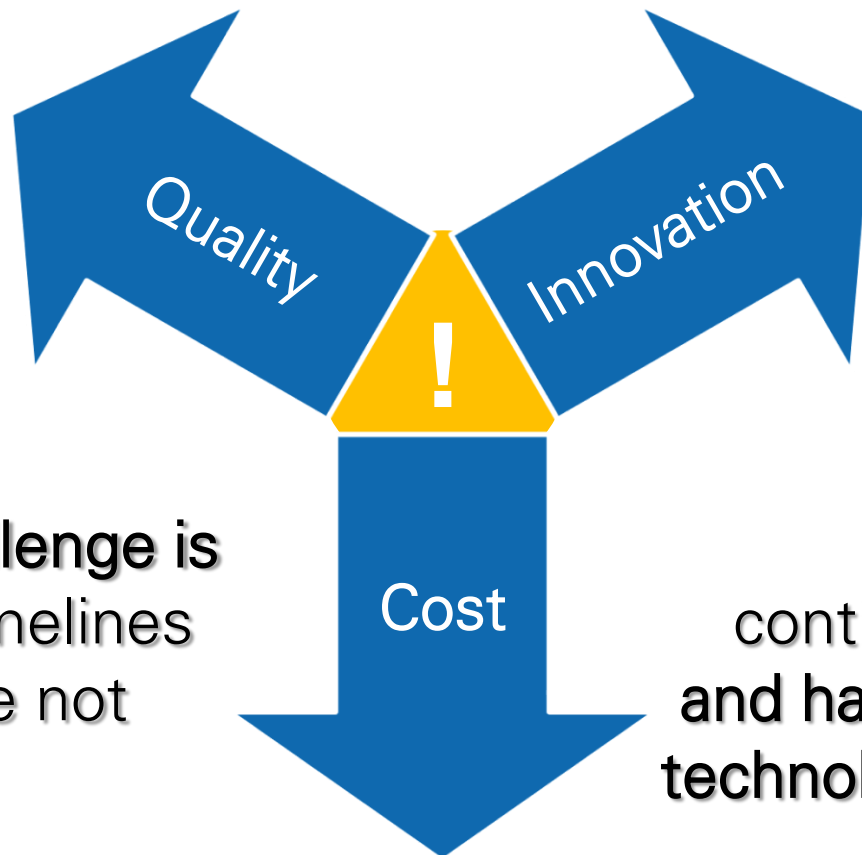
Defects

1k – 2k

65k - 130k

100k – 200k

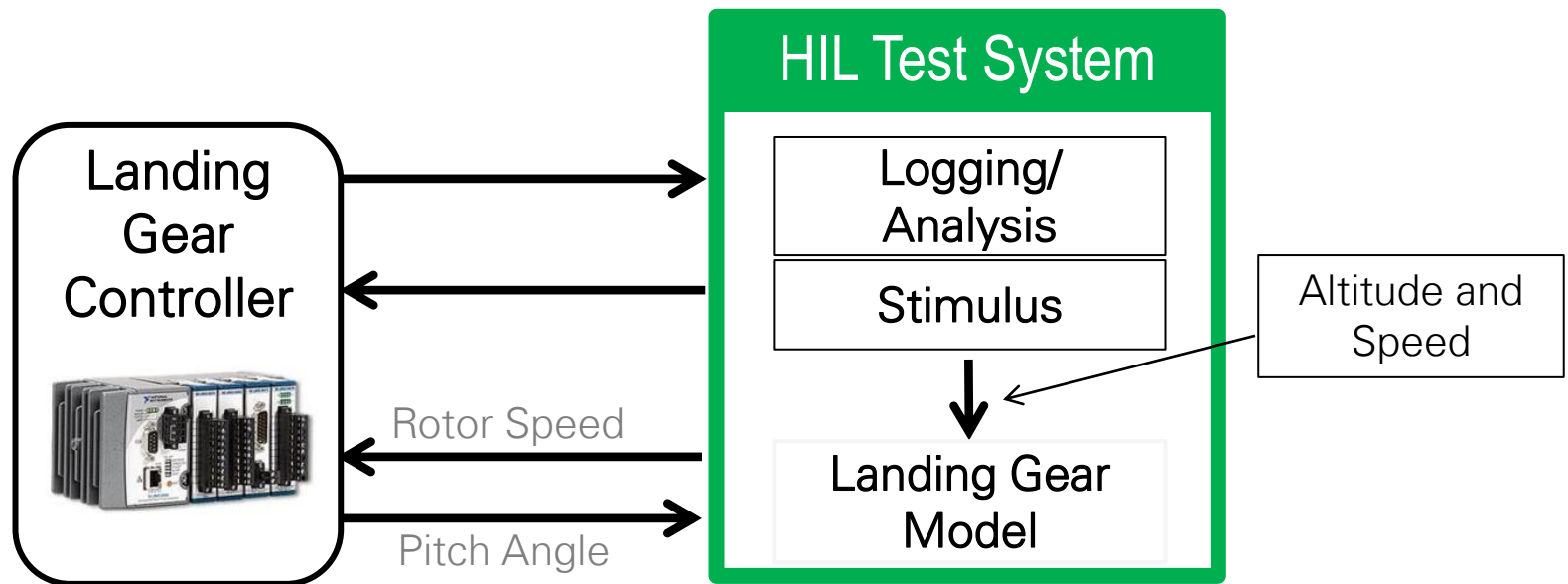
Diverging Challenges



The **quality challenge** is **growing**, but timelines and budgets are not increasing proportionally

Engineers must continue to **innovate and harness the latest technologies** to remain competitive

Hardware-in-the-Loop Test Systems



Real-Time Testing Software Functionality

Application Architecture

- Stimulus Generation
- Data Logging
- Single-Point I/O
- Alarming
- Calculated Channels
- Run-time Editable User Interface
- User Management
- Multi-Chassis Synchronization
- Closed-Loop Control
- Deterministic Model Execution



NI VeriStand™

Real-Time Testing and Simulation Software

- Stimulus Generation
- Data Logging
- Single-Point I/O
- Alarming
- Calculated Channels
- Run-time Editable User Interface
- User Management
- Multi-Chassis Synchronization
- Closed-Loop Control
- Deterministic Model Execution



RT PXI



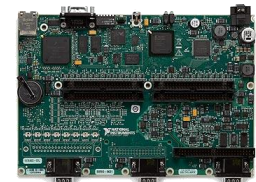
RT PC



Industrial Controller



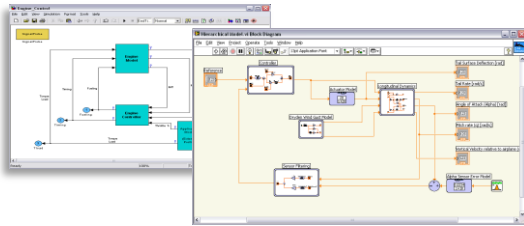
NI CompactRIO



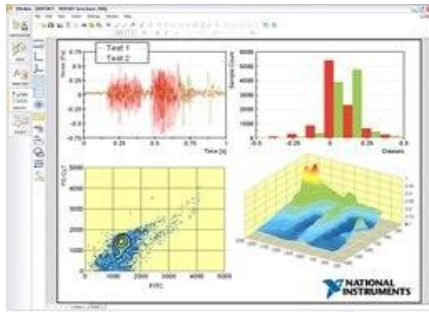
NI Single-Board RIO

NI Real-Time Testing Platform

Modeling and Simulation



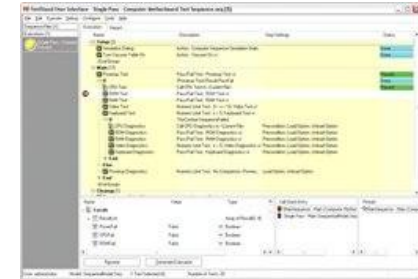
Analysis and Reporting



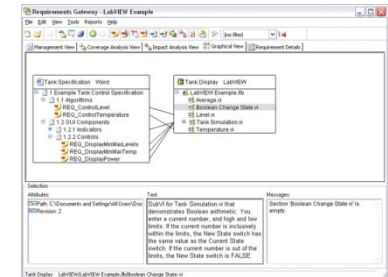
Real-Time Testing



Test Automation



Requirements Traceability



Real-Time
Processor



Analog/
Digital I/O



Bus
Interfaces



Fault
Insertion



Instrument
Grade and RF I/O



Vision/
Motion



PXI Avionic Bus Interfaces



A banner with a grey background on the left containing the text "COMPATIBLE WITH" in white. To the right of this is the National Instruments LabVIEW logo, which includes a yellow triangle with a black plus sign inside, flanked by green and blue wavy lines, and the text "NATIONAL INSTRUMENTS" in blue above "LabVIEW" in large black letters.



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- High-performance MIL-STD-1553, ARINC-429, and ARINC-664 PXI interfaces from AIT
- Combine communication with other I/O in a single PXI-based platform
- Powerful software tools and a 'Compatible With LabVIEW' driver to increase efficiency and reduce testing costs



FADEC
APU
Flight Controls
Avionics
Landing Gear

“We selected [NI VeriStand](#) for our Legacy 500 Iron Bird because of the breadth of functionality the environment provides out of the box, which [significantly reduces our development efforts.](#)”

- M.A. Pires, Testing Device Development Coordinator, Embraer

Summary

